

Search Notes

Application/Control No.

10/553,684

Examiner

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Applicant(s)/Patent under
Reexamination

YATABE, FUMIO

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	399	8/10/2006	HHH
123	299	8/10/2006	HHH
123	300	8/10/2006	HHH
123	305	8/10/2006	HHH
123	494	8/10/2006	HHH
73	118.2	8/10/2006	HHH
update	search	1/17/2007	HHH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/10/2006	HHH
	1/17/2007	HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner